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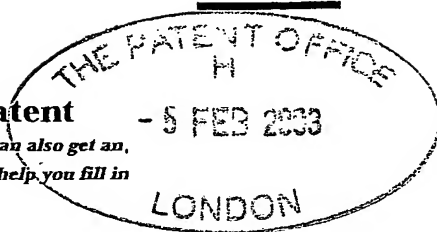
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NP9 1RH

1. Your reference

MMP/jl/FFI-007

2. Patent application number

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05 FEB 2003

0302664.8

3. Full name, address and postcode of the or of each applicant (underline all surnames)

07532229002

Patents ADP number (if you know it)

FAIRFIELD IMAGING LIMITED
10 LONSDALE GARDENS
TUNBRIDGE WELLS
KENT TN1 1NU

If the applicant is a corporate body, give the country/state of its incorporation

GB

4. Title of the invention

MICROSCOPE SYSTEM AND METHOD

5. Name of your agent (if you have one)

BROOKES BATCHELLOR

"Address for service" in the United Kingdom to which all correspondence should be sent (including the postcode)

102-108 CLERKENWELL ROAD
LONDON
EC1M 5SA

Patents ADP number (if you know it)

08142291001

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Country

Priority application number
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Date of filing
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Number of earlier application

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Request for preliminary examination and search (Patents Form 9/77) 1 ✓

Request for substantive examination (Patents Form 10/77) ✓

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11.

I/We request the grant of a patent on the basis of this application.

Signature
Brookes Batchellor

Date
4 February 2003

12. Name and daytime telephone number of person to contact in the United Kingdom

Madeline M Picker
BROOKES BATCHELLOR

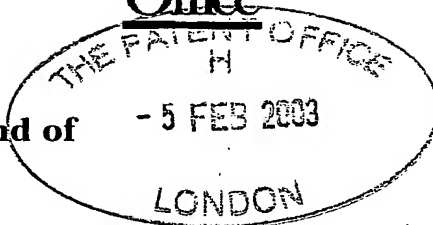
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South Wales
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2. Patent application number (if you know it)	05 FEB 2003	0302664.8				
3. Full name of the or of each applicant	FAIRFIELD IMAGING LIMITED					
4. Title of the invention	MICROSCOPE SYSTEM AND METHOD					
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Signature	Date					
Brookes Buchanan	4 February 2003					
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John R Maddison
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Patents ADP number (if you know it):

08434375001

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MICROSCOPE SYSTEM AND METHOD

The present invention relates to the field of microscopy, and in particular to an aid for a microscope user.

5

Microscopes are commonly used to view images of very small objects. A typical optical microscope has several objective lenses, of different magnifying power, to enable an object on a microscope slide to be viewed at different magnifications.

10

A problem with viewing an object through a microscope is that only a portion of the object can be seen in the field of view at any one time. The higher the magnifying power of the objective lens, the smaller the area of the object visible in the field of view. Thus, at very high magnifications (e.g. use of a 20x (or above) objective lens), the field of view only contains a very small part of the complete object.

15

Consequently, characteristic features of the object, such as its outline shape, or the distinctive shape of features within the object, are unlikely to be visible in the field of view, or, if visible are unlikely to be of a size sufficient to enable determination of the position of the visible area within the overall specimen.

20

When using a microscope for studying a biological specimen, for example, a user will typically look at the specimen on the microscope slide with the naked eye (e.g. by holding the slide up to the light) to get a sense of the outline shape of the specimen and the location of distinctive visible features within the outline. The user may then view the object through the microscope at low magnification to more clearly identify the main distinctive features of the object before viewing the object in detail at high magnification.

25

30

When viewing the specimen at high magnification, the user estimates the position of the portion of the specimen in the field of view within the overall specimen based on his or her memory of the shape of the specimen. As a result, even the most experienced microscope users find it difficult to determine the exact position of a part

of the specimen contained within a field of view in relation to the overall specimen, especially at high magnifications.

Recently, developments have been made in the field of "virtual microscopy" in which digital images of an object are captured from a microscope by a digital camera and assembled together by image processing software to form an overall image of the object which can be displayed on a display screen. An example of a virtual microscopy technique is described in EP-A-0 994 433 in the name of the present applicant. In the described technique, adjacent images are captured from a microscope at high magnification/resolution and are assembled together to provide a composite image. A low magnification/resolution copy of the image is obtained by image processing which is displayed on a display screen and used as a "navigation map". A user can select, from the navigation map, a portion of the low magnification/resolution image for viewing at high resolution. Thus, the user of a virtual microscope has the benefit of knowing the positional relationship of a displayed high magnification image relative to the overall object.

Although virtual microscopy is increasingly used, it necessitates the provision of an expensive, high precision microscope that is dedicated to imaging microscope slides, along with associated equipment including a stage driver, high quality digital or video camera and associated workstation. Such additional equipment can be bulky, and can inhibit normal use of the microscope when not performing imaging for virtual microscopy.

It would be desirable to provide a system and method which can be used with a conventional microscope that provides some of the aforementioned advantages of virtual microscopy. In particular, it would be desirable to provide a method and apparatus that gives an indication of the position of an area of a microscope specimen, contained within the field of view of a microscope, within the complete specimen.

One method for determining the position of an area of a microscope specimen contained within the field of view of a microscope within the complete specimen is to use an expensive robotic microscope stage which has a stage driver and sensors in order to determine the position of the field of view using the stage coordinates.
5 However this technique is complex and requires expensive equipment not readily available to an average microscope user.

The present invention therefore further aims to obviate the need for such expensive equipment when determining the positional information.

10 According to a first aspect, the present invention provides a method for determining a position of an area of an object, the image of which is contained within a field of view of a microscope, within the complete object, the method comprising acquiring digital image data representing a low magnification image of the complete object; thereafter,
15 acquiring high magnification digital image data representing an image of the field of view of a microscope; processing the high magnification digital image data to reduce the resolution thereof; comparing the processed high magnification digital image data with portions of the low magnification image data, and, determining said position to correspond to the position of a closest matched portion of the low magnification
20 image data.

The determined position can thus be provided to the user, for example by displaying an image of the complete specimen, using the low magnification image data, on a display screen and highlighting the area of the image corresponding to the field of
25 view.

Advantageously, the method can be carried out without special equipment. For instance, the low magnification image data may be acquired using a conventional scanner; the high magnification image data may be acquired using a digital camera in
30 conjunction with a conventional microscope, and the processing of the image data may be performed by a conventional computer or similar processing device.

According to a second aspect, the present invention provides a computer readable medium including a computer program comprising a program step for receiving high magnification image data representing the image of a part of an object contained in the field of view of a microscope; processing the high magnification image data to
5 reduce the resolution thereof; a program step for comparing the processed high magnification image data with portions of low magnification image data for the complete object stored in a data store, and, a program step for determining the position based on the results of the comparison.

10 Other preferred features and advantages of the present invention will be apparent from the following description and accompanying claims.

Embodiments of the present invention will now be described, by way of example, with reference to the accompanying drawings, in which:

15

Figure 1 illustrates an apparatus in accordance with an embodiment of the present invention;

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Figure 2 is a flow diagram illustrating the method of a preferred embodiment of the present invention;

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Figure 3 is a flow diagram illustrating the program steps carried out by a preferred computer program used to implement the method of the preferred embodiment of the present invention;

Figure 4 shows a low magnification image of a specimen for use in the method of the present invention, and

30

Figure 5 is a screen shot illustrating the presentation, to a user, of the position of a high magnification image of a part of the specimen of Figure 4 within the complete specimen, determined in accordance with the present invention.

Figure 1 shows an example of the apparatus used to implement the present invention. Except where otherwise stated, the apparatus takes conventional form and is typically apparatus that is readily available to a microscope user.

5 The apparatus comprises a microscope 1 including a movable stage 3, and a digital camera 5 connected to a camera attachment of the microscope 1 for capturing images of the microscope field of view. It should be noted that, as well as the camera attachment, the microscope 1 has a separate eyepiece or eyepieces (not shown) to enable a user to use the microscope 1 whilst the camera 5 is attached thereto.

10 The digital camera 5 is also coupled to provide digital microscope images to a workstation 7, which may be any conventional computer having a processor and memory, that is capable of receiving and storing the digital image data from the camera 5. The workstation 7 has user interfaces including a display screen 9, a
15 keyboard 11 and a mouse 15, and peripheral devices including a printer 17 and a flatbed scanner 19.

The workstation 7 is loaded with a computer program in accordance with a preferred embodiment of the present invention. In particular, the computer program
20 implements a method that determines positional information relating to an object under the microscope, namely, the position of an area of an object, the image of which is contained within a field of view of the microscope 1, relative to the complete object. In addition, the computer program provides the determined positional information on the display screen 9, as described in further detail below.

25 Figure 2 is a flow diagram of a preferred method for determining a position of an area of a specimen on a microscope slide 21 (as shown in Figure 1), the image of which is contained within a field of view of the microscope 1 (as shown in Figure 1), relative to the complete specimen, in accordance with the present invention.

At step 10, low magnification image data of the complete specimen is acquired and stored in memory in workstation 7. Figure 4 depicts, by way of example, low magnification image data, for a biological specimen on the slide 21, acquired by step 10.

5

Typically step 10 is performed by scanning the microscope slide 21, containing the specimen, without magnification or enlargement of the image, using the flatbed scanner 19 to achieve the highest possible image resolution for the scanner (e.g. 600, 1200 or 2400 dpi). Since there is no magnification, the quantity of image data is kept to a manageable size (e.g. 4000 pixels square for a specimen of 20 mm x 20 mm) for processing. It will be appreciated, however, that any appropriate manner of acquiring high resolution digital image data without significant magnification may be used, for example, scanning using a digital photocopier or taking a single image of the complete specimen using a high quality digital camera that can provide similar resolutions to a scanner, as specified above. It will be further appreciated that low level magnification (e.g. use of 2x objective lens) may be desirable in some circumstances and may be used if the quantity of data is manageable (i.e. it can be processed in a reasonable length of time).

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At step 20, the display screen 9 displays an image 23 of the complete specimen (or a significant proportion thereof) on the slide 21 represented in the image data acquired at step 10. This image, labelled 23 in Figure 5, provides the user with a quick reference to the outline shape and characteristic features of the specimen.

25

At step 30, the user places the slide 21 of the specimen, as shown on the display screen 9, under the microscope 1, and positions the stage 3 at an arbitrary starting point for viewing the specimen.

30

At step 40 the digital camera 5 takes an image of the microscope field of view and forwards the high magnification image data thus acquired to the workstation 7, which

is stored in memory and displayed on the display screen 9 as a field of view image 25, as shown in Figure 5.

At step 50, the workstation 7 processes the high magnification data so as to reduce the resolution thereof. In particular, since the high magnification image data represents only a small area of the complete specimen, the resolution thereof is higher than the resolution of the part of the low magnification image data that represents an area of the specimen of the same size. Accordingly, the high resolution image data is processed by conventional image decimation, or similar techniques, to provide processed reduced resolution image data representing the field of view image such that the processed image data has a similar resolution to that of a corresponding portion of the low magnification image data of the complete specimen. The correct reduction in resolution is achieved by pre-calibrating the system, as discussed below.

At step 60, the workstation 7 compares the data for the reduced resolution image of the current field of view with the low magnification image data for the complete specimen to determine if a "possible match" can be found. The comparison may be carried out, for example, using cross correlation techniques, as well known to a person skilled in the art. In the preferred embodiment, the workstation has a predetermined threshold, for each microscope objective lens, that defines the percentage of identical data in the low magnification and high magnification image data necessary in order to for there to be a "possible match". Each time a possible match is found in the low magnification data, the position thereof is recorded.

Following comparison of the reduced resolution field of view image data with the complete low magnification image data, if a single possible match is found, then the location of the area of the specimen in the field of view is determined to correspond to that of the matched area of the image of the complete specimen. In this case, at step 70, the display screen 9 highlights the area of the low magnification image displayed that matched with the field of view data, as shown by a box in Figure 4.

If more than one possible match is found, the best or closest match may be highlighted on the display (i.e. the part of the low magnification image having the highest percentage of identical data to the high magnification field of view image data). If no match is found (i.e. no part of the low magnification image data has a percentage of identical data exceeding the threshold), at step 80, the display screen 9 indicates this on or adjacent to the displayed image of the specimen (e.g. by the words "Position Unknown").

In a preferred embodiment, at least a part of the method of the present invention, as illustrated in Figure 2, is implemented in the form of a software application which may be provided in the form of a computer program on a computer readable medium. Such a computer readable medium may be a disk, which can be loaded in a disk drive of the workstation 7 of the system of Figure 1. Alternatively, if the workstation 7 is connected to a network, the program may be held in a server carrying a website, which permits downloading of the program over the Internet by the workstation. Thus, the present invention may be embodied in the form of a carrier wave with the computer program carried thereon.

Figure 3 illustrates the program steps carried out by a computer program in accordance with a preferred embodiment of the present invention. The computer program is loaded in workstation 7, which receives image data from digital camera 5 and flatbed scanner 19 as discussed above.

It is assumed that prior to the start of the program illustrated in Figure 3, the user initiates the system, and, if necessary, performs calibration of the system (this is usually only required when the program is used with a system for the first time, or new equipment is installed in the system).

Conventional calibration of each objective lens of the microscope in conjunction with the camera, and calibration of the scanner is necessary, and the skilled person would be familiar with the necessary techniques involved, and a detailed discussion thereof

is unnecessary. Briefly, a calibrated graticule is used with the microscope and camera to measure the number of pixels per unit length represented in the high magnification image data, and thus the resolution thereof. Similarly, a calibrated graticule is used with the scanner to measure the number of pixels per unit length represented in the low magnification image data, and thus the resolution thereof. From this calibration information, the program calculates the relative resolutions of the image data for the microscope and the camera.

The program is initiated by a user, and low magnification image data from the flatbed scanner 19 or other image data source is received and stored in the workstation memory and displayed on display screen 9 using conventional software (step 10 of the method of Figure 2) prior to the program steps illustrated in Figure 3. It will be appreciated that in other embodiments, the computer program may include the necessary program steps to perform the scanning step.

In accordance with a preferred embodiment, the camera is set up to capture field of view images at its highest speed (e.g. 30 frames per second) and the program runs continuously, following initiation by the user for a particular specimen. Thus, the workstation continuously receives field of view images.

At step 100, the program receives field of view image data from the digital camera 5. Any field of view image data received from camera 5 during subsequent processing steps 110 to 170 are not processed and may be overwritten in workstation memory. The field of view image data currently being processed is retained in memory (and displayed on the display screen 9) until the program returns to step 100, as described below.

At step 110, the program reduces the resolution of the field of view image data to a resolution approximating that of a corresponding area of the image data of the complete specimen received from the scanner 19 and stored in memory, to obtain reduced resolution field of view image data. The reduction in resolution is

determined based on the calibration data for the scanner and the objective lens of the microscope and camera from which the image data is acquired, as discussed above.

At step 120, the program performs cross correlation of the reduced resolution field of view image data obtained at step 110 with the low magnification image data of the complete specimen stored in memory, and stores the location of portions of the low magnification image data for each possible match. As explained above, it will be appreciated that a possible match is determined based on the quantity of identical data in both sets of image data, a possible match being identified if the proportion of identical data exceeds a preset threshold for each objective lens of the microscope. For example, a percentage of identical data that may be considered to be a threshold for a potential match may be 25%. In practice, a match is likely to exist if the percentage of identical data is in the range of 50% to 90% (it should be appreciated that a 100% match is statistically improbable). In the preferred embodiment, the user is able to adjust this threshold based on the results, and thus interactively adjust the system to provide the most accurate position determination. Thus, if the threshold is set too high, the system will not be able to locate the position in most cases, and the user is able to reduce the threshold in order to achieve better position determination.

At step 130, the program considers if the cross correlation resulted in at least one possible match between the reduced resolution field of view data and the low magnification data for the complete specimen.

If step 130 determines that the cross correlation resulted in a single possible match of the field of view image data in the overall specimen image data, the program continues with step 140, and sends a signal to the display screen to display an indication of the location of the matched portion of the image of the complete specimen (e.g. by highlighting in colour, or, as shown in Figure 5, surrounding by a box, the area of the complete specimen image on the display corresponding to the matched image data).

Alternatively, if step 130 determines that the cross correlation did not result in a single match of the image data, the program continues with step 150, by considering whether more than one possible match of the image data was found by the cross correlation at step 120.

5

If step 150 determines that the cross correlation performed at step 120 did not result in more than one possible match, then no possible match has been found, and at step 170, the program sends a signal to the display screen 9 to display that the location of the field of view cannot be determined, in the present example, by displaying the words "Position Unknown".

10

Alternatively, if step 150 determines that the cross correlation performed at step 120 did result in more than one match (which is unlikely for most biological specimens, but may occur for other types of objects), in accordance with the preferred embodiment, at step 160, the program selects the closest matched area of the low magnification image (i.e. the area of the high magnification image data with the highest percentage of identical data to the reduced resolution field of view data), and sends a signal to the display screen 9 to highlight this closest matched area in the complete specimen image. In this case, the manner of highlighting is preferably different from the highlighting used in response to step 140 where a single possible match is found.

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In another embodiment, step 160 may instead send a signal to the display screen 9 to highlight all the matched portions of the image of the complete specimen. In this case, again, an alternative form of highlighting is desirable to distinguish from the definite match at step 140.

25

After the program has sent a signal to the display screen 9, at step 140, 160 or 170, the program returns to step 100 and commences processing the next field of view image to be received from the camera 5 which is then immediately displayed on the display screen 9 and stored in memory.

30

In view of the likelihood of only a single match occurring for certain types of object, in another embodiment, steps 150 and 160 may be omitted. Thus, in this embodiment, if step 130 determines that the cross correlation did result in a (single)
5 match, the program proceeds to step 140, and if step 130 determines that the cross correlation did not result in a (single) match, the program proceeds straight to step 170.

As mentioned above, Figure 4 illustrates, by way of example, the image of a specimen
10 on slide 21 acquired by the low magnification scan in accordance with the present invention. This low magnification image, or a part thereof, is displayed on display screen 9, as shown in Figure 5 and described below, when the program of Figure 3 is used in conjunction with the system shown in Figure 1.

As shown in Figure 5, in a preferred embodiment, the display screen 9 includes two
15 separate display areas; a main area displays the current, magnified, high resolution field of view image of the microscope 1, labelled 25 in Figure 5, and a secondary area displays the low magnification image of the complete specimen (or a proportion thereof), labelled 23 in Figure 5. The display may also include a toolbar 17 and an
20 information area 29 providing identifying information about the current specimen and/or system equipment.

In the preferred embodiment, and as shown in Figure 5, when the program is in use, the displayed low magnification image 23 does not show the complete specimen (as
25 shown in Figure 4) but rather shows a significant proportion of the area of the specimen surrounding the identified position of the current field of view image 25. It will be appreciated that initially, or when using a lower magnification objective lens (in the illustrated example, a 10x objective lens is used to obtain the field of view image), the complete specimen may be shown in the secondary area of the display,
30 and used as the navigation map.

As shown in Figure 5, an area is highlighted by dashed outline in the low magnification image of the specimen 23, which area corresponds to, and represents the position within the complete specimen of, the high magnification field of view image 25. The highlighted area changes each time the position of the stage 3 of the microscope 1, and thus the specimen, is moved. In this way, displayed image 23 provides a navigation map of the specimen which enables the user to easily locate the current position of the field of view image, and to determine the relative positions of other features of interest in the specimen.

Whilst the preferred embodiment of the present invention has been described for use with an optical microscope, it will be appreciated that the present invention may be used with other types of microscope.

Various modifications and changes may be made to the described embodiments. It is intended to include all such variations, modifications and equivalents that fall within the scope of the present invention as defined in the accompanying claims.

CLAIMS:

1. A method for determining a position of an area of an object, the image of which is contained within a field of view of a microscope, within the complete object,
5 wherein image data representing a low magnification image of the complete object is available; the method comprising; acquiring high magnification image data representing an image of the field of view of the microscope; processing the high magnification image data to reduce the resolution thereof; comparing the processed high magnification image data with portions of the low magnification image data,
10 and, determining said position based on the results of said comparison.
2. A method as claimed in claim 1, in which the comparison determines a percentage of identical data in each compared portion of the low magnification image data and the processed high magnification image data
15
3. A method as claimed in claim 1 or claim 2, in which a position is determined if the determined percentage of identical data for at least one portion of the low magnification image data exceeds a predetermined threshold.
- 20 4. A method as claimed in claim 3, in which the step of determining said position based on the results of said comparison comprises determining the position as the position of the, or one of the, at least one portion of the low magnification image data.
5. A method as claimed in claim 4, in which, if the percentage of identical data
25 for more than one portion of the low magnification image data exceeds the predetermined threshold, the position is determined as the position of the portion with the highest percentage of identical data.
6. A method as claimed in any one of claims 1 to 5, in which the processing
30 comprises reducing the resolution by a predetermined amount.

7. A method as claimed in claim 6, in which the predetermined amount is a factor determined by calibration of an apparatus from which the low magnification image data is acquired, and calibration of the microscope.

5 8. A method as claimed in any preceding claim, further comprising displaying an image of the complete object and of the field of view of the microscope on a display screen, and highlighting the area of the image of the complete object corresponding to the determined position.

10 9. A method as claimed in any preceding claim, further comprising, initially acquiring said low magnification image data from a high resolution image data source.

15 10. A method as claimed on claim 9, wherein the image data source is one of a scanner, digital photocopier and a high resolution digital camera.

11. A method substantially as hereinbefore described with reference to, and as illustrated in, the accompanying drawings.

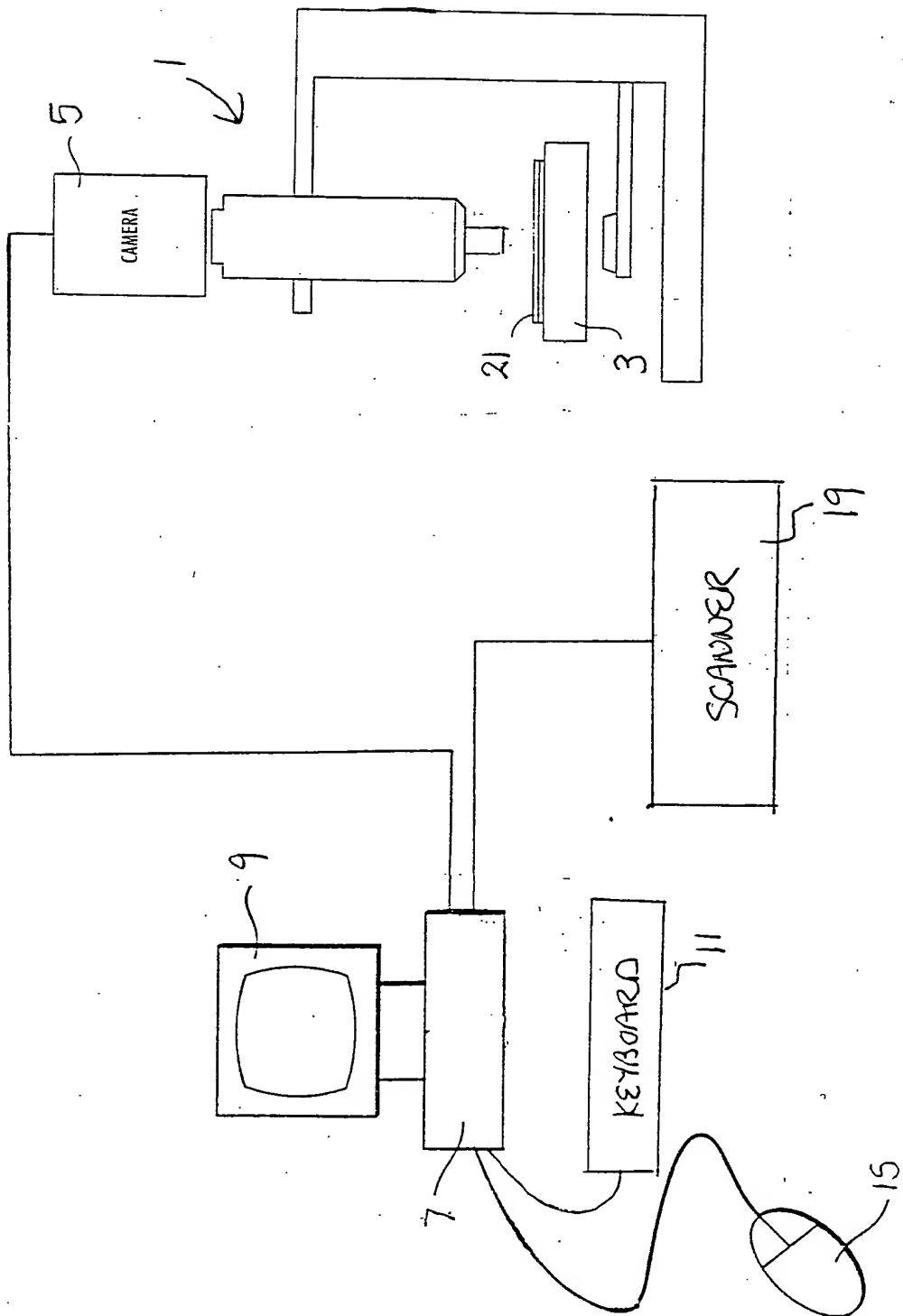
20 12. A computer readable medium comprising a computer program for carrying out the method as claimed in any preceding claim.

ABSTRACT
MICROSCOPE SYSTEM AND METHOD

A microscope system and method is described for determining a position of an area of an object, the image of which is contained within a field of view of a microscope 1, within the complete object. Image data representing a low magnification image of the complete object is available for use in the method, and may be acquired using a low magnification image data source such as a scanner 19. The method comprises acquiring high magnification image data representing an image of the field of view of the microscope 1, typically from a digital camera 5 attached to the microscope 1; processing the high magnification image data to reduce the resolution thereof; comparing the processed high magnification image data with portions of the low magnification image data, and, determining said position based on the results of said comparison. In a preferred embodiment, the method is implemented in the form of a computer program running on a workstation 7, which displays, on a display screen 9 the field of view image 25, and the image of the complete object, in which the position of the area of the object 23a in field of view is highlighted.

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FIGURE 1



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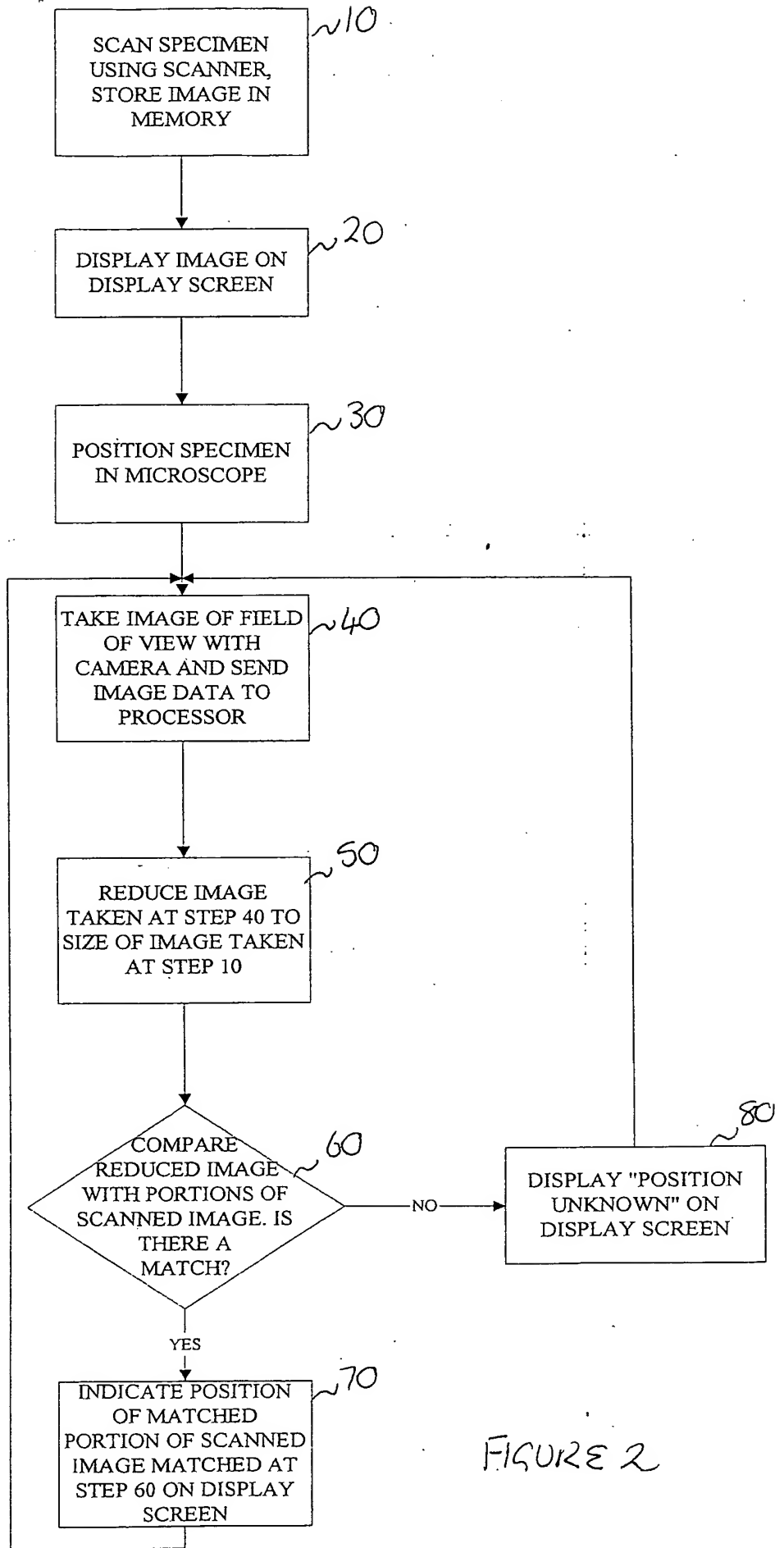


FIGURE 2

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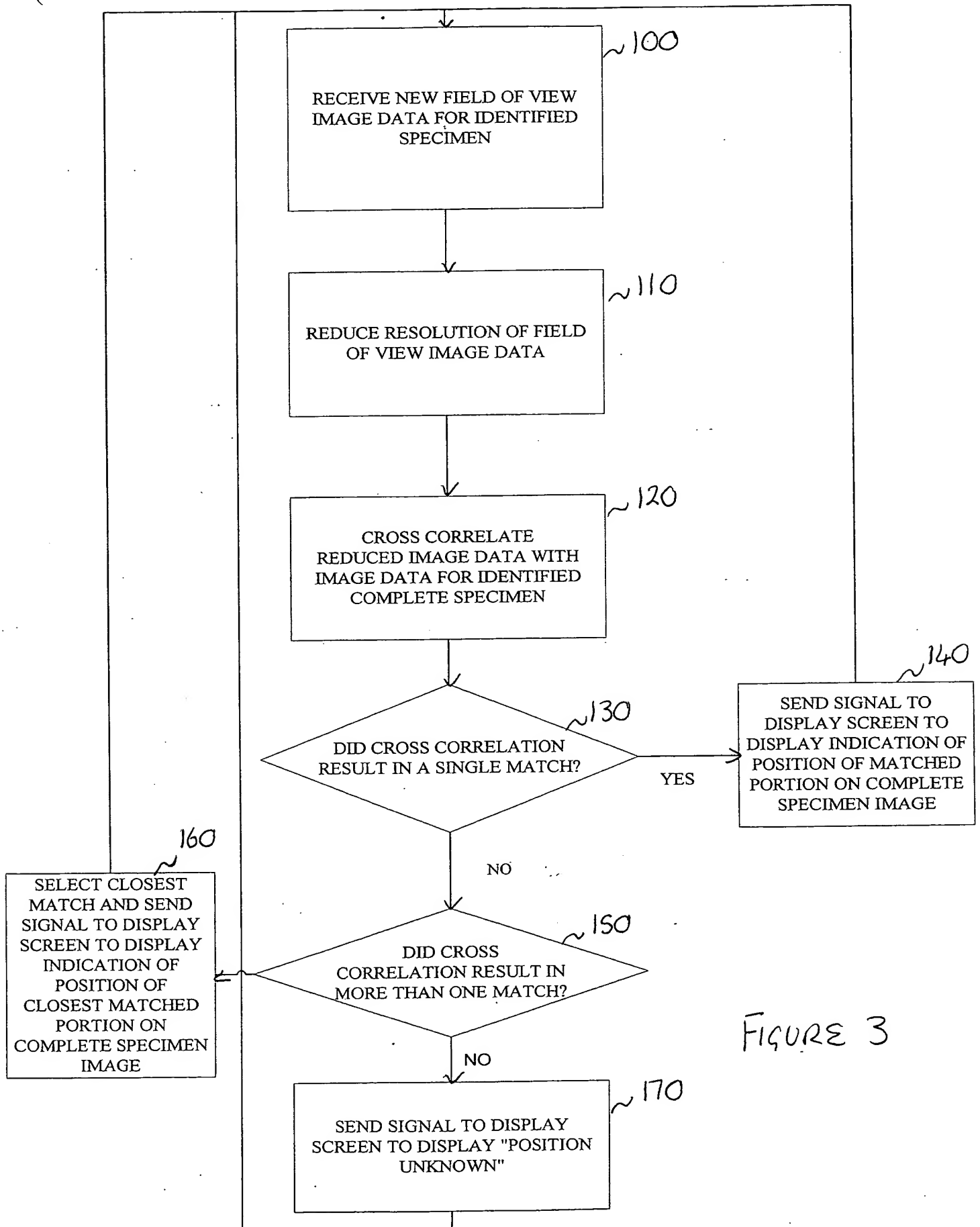
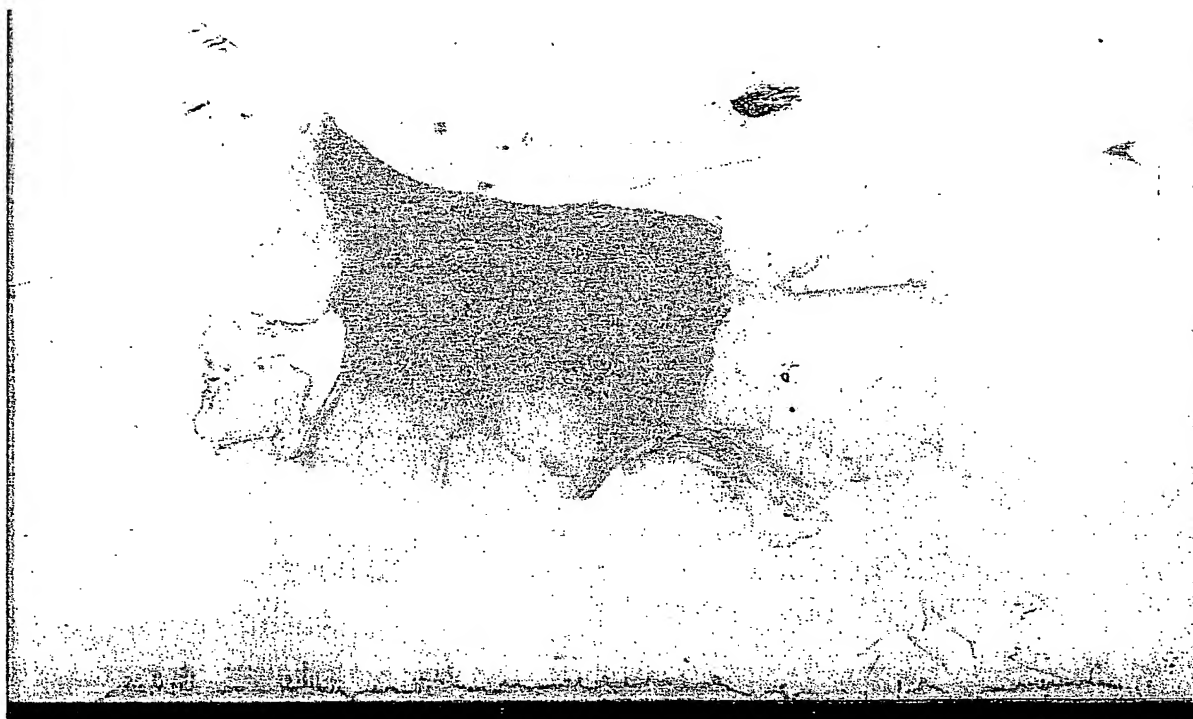


FIGURE 3

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Low Magnification image from Slide Scanner

FIGURE 4

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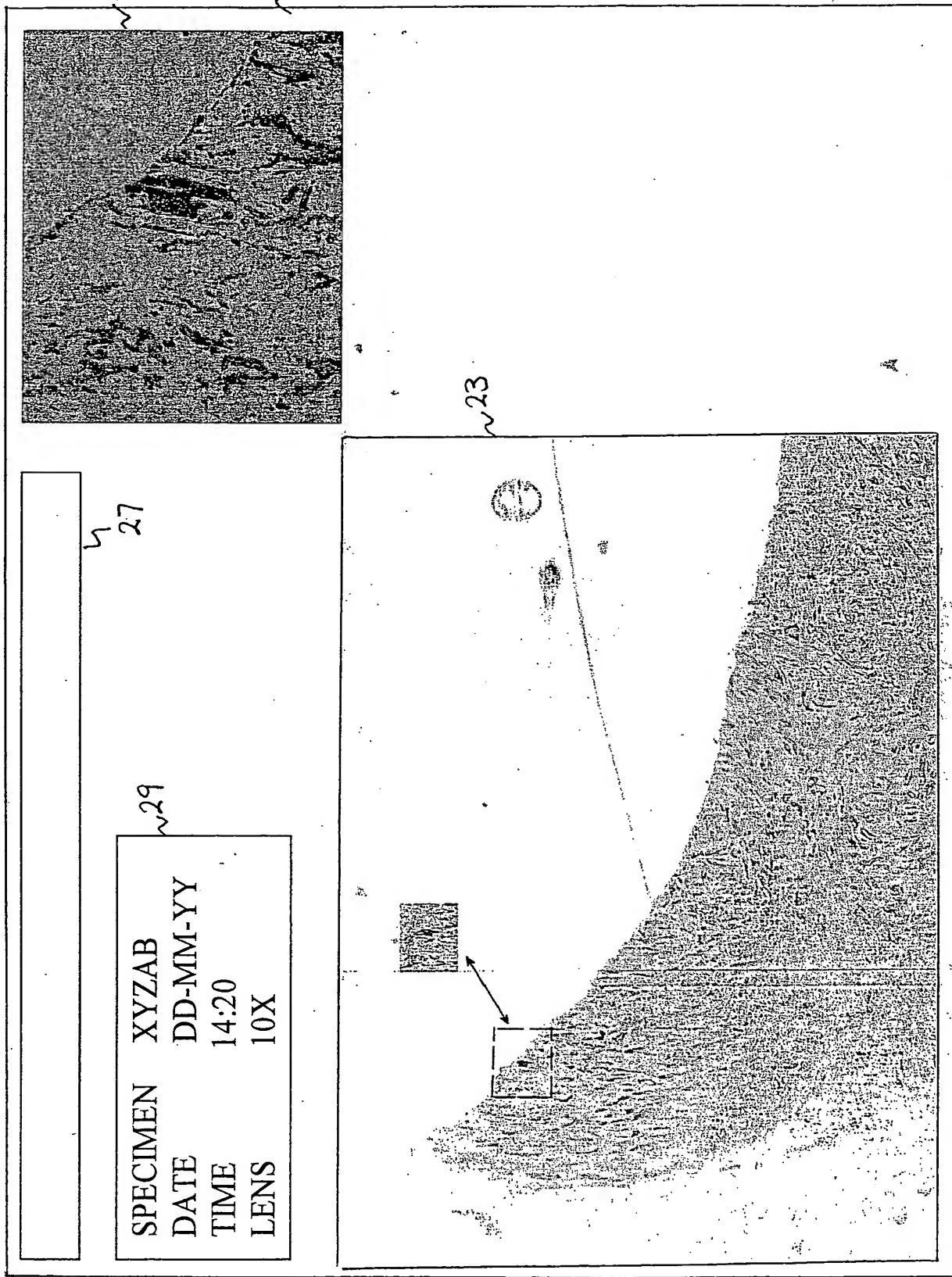


FIGURE 5

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